Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination NAKANISHI ET AL. Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,363,226	11-1994	Strasser et al.	359/566
	В	US-5,910,940	06-1999	Guerra, John M.	369/275.1
	С	US-5,726,805	03-1998	Kaushik et al.	359/589
	D	US-5,561,558	10-1996	Shiono et al.	359/569
	Е	US-2005/0002313	01-2005	Hayashi, Kenichi	369/112.03
	F	US-			
	G	US-			
	Н	US-			
	-	US-			·
	J	US-			
	κ	US-			v
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q			,		·
	R					
	S					
	Τ.					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.